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418 cm^{-1} Raman scattering from gallium nitride nanowires: Is it a vibration mode of N-rich Ga–N bond configuration?

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A Raman-active vibration mode at 418 cm^{-1} is observed in wurtzite gallium nitride (GaN) nanowires synthesized by different growth methods. In particular, Raman scattering measurements of a number of GaN nanowires systematically prepared by nitriding $\beta\text{-Ga}_2\text{O}_3$ nanowires at different temperatures show an interesting evolution of the mode, revealing that it is most likely the vibration mode of N-rich octahedral Ga–N₆ bonds. This idea is further supported by the high-resolution transmission electron microscopic observation. © 2007 American Institute of Physics.

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In the past decade, the GaN-based optoelectronic industry has grown rapidly. More recently, various forms of GaN nanomaterials such as nanorods and nanowires have attracted a great deal of attention as these nanosized GaN materials are expected to exhibit superior optical and electrical properties that may greatly extend applications of GaN-based materials. For example, GaN nanorods and nanowires have been used to fabricate light-emitting diodes¹ and field-effect transistors.² Further exploitation of devices based on GaN nanomaterials demands a better understanding of the properties of such nanomaterials. Raman scattering is a powerful tool to characterize the structural, compositional, and lattice vibrational properties of a material. The application of this powerful technique to GaN nanomaterials has led to a recent observation of a 418 cm^{-1} vibration mode.^{3–5} In fact, a careful literature search shows that this Raman peak had been reported earlier in significantly disordered GaN epilayers.^{6,7} However, its microstructural origin is still a debated issue. This letter, which is motivated by the noticeable appearance of this Raman mode, shows that it most likely originates from abundant regional N-rich Ga–N bond configurations that exist in various GaN nanostructures and some strongly defected GaN films.

We start our discussion from the typical Raman spectra measured from two kinds of GaN nanostructures synthesized by different methods, as shown in Fig. 1. The Raman spectra were measured at room temperature under the backscattering geometric configuration using WITec-Alpha confocal micro-Raman system. The excitation light was the 514.5 nm line of an Ar⁺ laser with 30 mW output power. During the measurements, the excitation light was focused onto the sample surface with a 60× Olympus objective. In Fig. 1, spectrum (a) was recorded from a GaN nanowire sample prepared on a Si substrate by chemical vapor deposition (CVD),⁸ while spectrum (b) was from another GaN nanowire sample obtained by nitriding Ga_2O_3 nanowires in NH_3 at 950°C for 30 min.

In addition to the characteristic Raman peaks at 564 and 720 cm^{-1} of wurtzite GaN, one peak at 418 cm^{-1} can be well seen in both the spectra. Besides this peak, another additional peak at 252 cm^{-1} is observed. Other peaks marked by asterisk are from the Si substrate. It is more interesting to note that spectrum (b) in Fig. 1 exactly resembles the Raman spectrum of the GaN hollow spheres obtained by Sun and Li.⁵ These consistent observations of the 418 cm^{-1} peak in the GaN nanostructures and in the strongly defected films prepared by different groups with a variety of techniques suggest that the Raman structure is likely to be a characteristic vibration mode of some unknown Ga–N bond configuration which exists abundantly in various forms of nano- and defected GaN structures.

Usually, Raman spectroscopic features of a material can be interpreted in terms of the vibrational density of states (VDOS) which is a measure of the vibrational excitations of the material. The VDOS of GaN has been well studied.^{9–11} The structures at 564 and 720 cm^{-1} can be readily identified since they just correspond to the TO and LO modes in the VDOS, respectively. However, for the peak at 418 cm^{-1} , no corresponding structure exists in the theoretical VDOS of

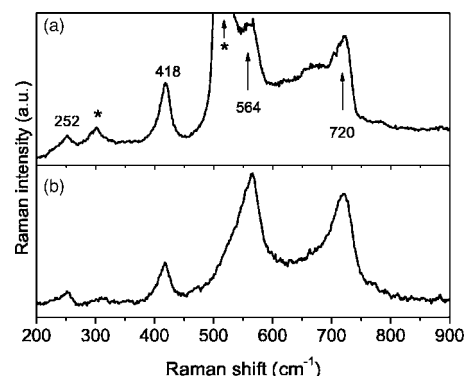


FIG. 1. Room-temperature Raman spectra of the two kinds of GaN nanowires: (a) grown by CVD and (b) obtained by nitriding Ga_2O_3 nanowires in NH_3 at 950°C for 30 min. The peaks marked by asterisk are from the Si substrate.

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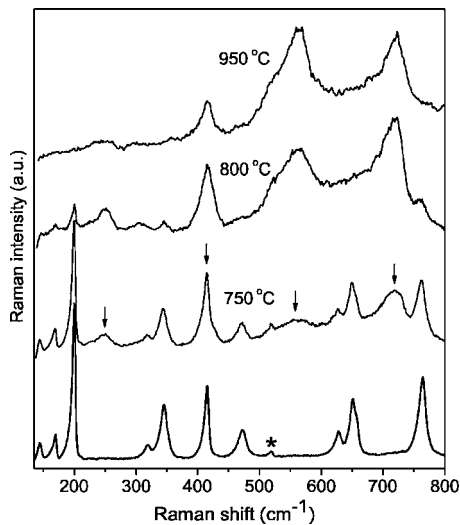


FIG. 2. Raman spectra of Ga_2O_3 nanowires nitrided at different temperatures. The fresh Raman peaks indicated by the vertical arrows are due to the formation of GaN compound. The 520 cm^{-1} peak marked by asterisk in the bottom spectrum is from the substrate Si on which the Ga_2O_3 nanowires were grown.

GaN because it lies in the phonon band gap between the acoustic and optical bands of GaN. The peak, therefore, cannot be explained even with disorder-activated Raman scattering and indeed it is not observed in either experimentally measured or theoretically calculated Raman spectra of amorphous GaN.^{9,12}

Figure 2 shows the Raman spectra of Ga_2O_3 nanowires nitrided at 750, 800, and 950 °C, respectively, under identical ammonia gas flow for 30 min. The typical Raman spectrum of pure $\beta\text{-Ga}_2\text{O}_3$ nanowires is also plotted for reference. In the reference spectrum, the sharp peaks stem from the different vibrational modes of $\beta\text{-Ga}_2\text{O}_3$ except for the 520 cm^{-1} peak of the Si substrate marked by an asterisk. From Fig. 2, one can clearly observe the evolution of the four GaN-related Raman peaks at 252, 418, 564, and 720 cm^{-1} indicated by vertical arrows. These peaks start to show up in the Raman spectrum of the Ga_2O_3 nanowires nitrided at 750 °C and gradually become dominant with increasing nitridation temperature. It is particularly interesting to note that the 418 cm^{-1} peak evolves from the Raman peak of $\beta\text{-Ga}_2\text{O}_3$ at 416 cm^{-1} . This provides an important clue about the microstructural origin of the 418 cm^{-1} peak.

Figure 3(a) shows a representative high-resolution transmission electron microscopy (HRTEM) image of a Ga_2O_3 wire nitrided at 750 °C. The horizontal fringes parallel to the wire axial direction are found to dominate in the image and have a spacing of about 2.81 \AA which corresponds to the d spacing of the $\beta\text{-Ga}_2\text{O}_3$ {002} lattice planes. These facts indicate that the majority of the wire is still $\beta\text{-Ga}_2\text{O}_3$ although it was nitrided at 750 °C. However, these horizontal fringes do not coherently prolong throughout the entire wire and are broken by many local blurred regions. These regions are believed to be the disordered grains where nitrogen atoms are already incorporated into the lattice of $\beta\text{-Ga}_2\text{O}_3$. Such a grain is indicated by a rectangle in Fig. 3(a). Besides the blurred regions, the lattice fringes in some local regions are clearly seen to be tilted at angles of 60° and 120° with respect to the [100] direction. We would like to point out that no corresponding lattice planes of the $\beta\text{-Ga}_2\text{O}_3$ phase possess such tilting directions or spacing between the tilting

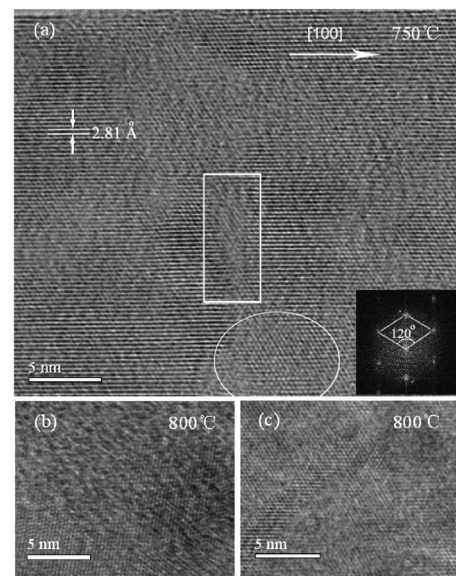


FIG. 3. (a) HRTEM image of a wire treated at 750 °C. The inset is selected-area electron diffraction (SAED) patterns showing hexagonal symmetry. (b) and (c) are the HRTEM images of different wires nitrided at 800 °C, respectively.

fringes. Furthermore, strong distortion of the horizontal fringes can be seen in these regions. For example, in such a region outlined by the elliptical line in Fig. 3(a), the oblique fringes become prominent and the horizontal fringes are significantly distorted. All these structural features can be well interpreted by the incorporation of nitrogen into the local regions. The inset in Fig. 3(a) shows the selected area electron diffraction (SAED) pattern of such a region. Interestingly, the hexagonal diffraction pattern can be seen although it is dimmed by the strong disorders in the region. It can be viewed as further supporting evidence of nitrogen incorporation into local Ga_2O_3 lattice regions. We thus conclude that the 750 °C nitridation in our case has led to the N incorporation and formation of local Ga–N bonds inside $\beta\text{-Ga}_2\text{O}_3$ lattice. Increasingly blurred regions with irregularly oriented fringes are thus expected in HRTEM images of the Ga_2O_3 nanowires nitrided at higher temperatures. Indeed, such expectation is verified in the two HRTEM images of the Ga_2O_3 nanowires nitrided at 800 °C, as shown in Figs. 3(b) and 3(c). This concurs with the observation of N incorporation made by one of us using x-ray photoelectron spectroscopy and photoluminescence measurements.¹³ In the local inclusions embedded into $\beta\text{-Ga}_2\text{O}_3$, the Ga–N bond configuration may be significantly different from the normal configuration in the GaN wurtzite phase. Two kinds of Ga–N bond configurations are postulated: one is GaN-like and the other Ga_2O_3 -like. GaN-like bonds exhibit vibrational properties which can be interpreted using the VDOS of GaN. For Ga_2O_3 -like Ga–N bonds, however, different vibrational properties such as the observed 418 and 252 cm^{-1} peaks are to be expected. It is known that the wurtzite-GaN lattice can be referred to as an arrangement of corner-sharing Ga– N_4 tetrahedra, whereas $\beta\text{-Ga}_2\text{O}_3$ consists of mixed edge-sharing Ga– O_6 octahedra and corner-sharing Ga– O_4 tetrahedra.¹⁴ The unique mixed bond configurations of $\beta\text{-Ga}_2\text{O}_3$ crystal thus give rise to more vibration modes than the pure wurtzite phase, as shown in the bottom Raman spectrum in Fig. 2. For instance, the 416 cm^{-1} peak is an intrinsic vibration mode exactly associated with the Ga– O_6 octahedra in the $\beta\text{-Ga}_2\text{O}_3$

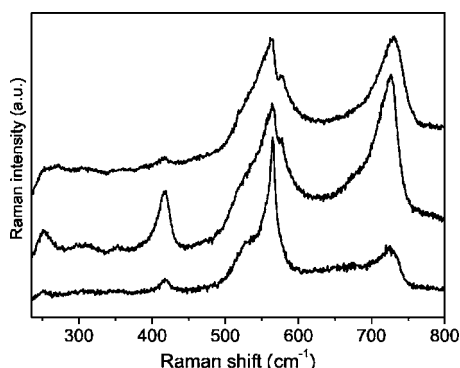


FIG. 4. Raman spectra measured from Ga_2O_3 nanowires nitrided in NH_3 under different conditions: the top at 1100°C for 20 min, the middle at 1100°C for 30 min, and the bottom at 1150°C for 20 min.

lattice.¹⁵ During the nitridation of $\beta\text{-Ga}_2\text{O}_3$ nanowires, N atoms are expected to replace O atoms either in Ga-O_6 or in Ga-O_4 bond configurations. The latter replacement will result in the formation of normal Ga-N_4 bonds while the former may lead to the formation of local Ga-N_6 octahedral structures. Of course, it should be pointed out that local Ga-N_x structures with $6 \geq x > 4$ might exist due to incomplete replacement chemical reaction during the nitridation process. These resultant N-rich local structures should bring about some fresh peaks in the Raman spectrum. As shown in Fig. 2, the close relationship between the 418 cm^{-1} peak of the GaN nanowires and the 416 cm^{-1} peak from the Ga-O_6 octahedral structure of $\beta\text{-Ga}_2\text{O}_3$ gives strong support for the existence of local Ga-N_6 octahedral structures. As the nitridation temperature is increased, more Ga-O_6 octahedral structures transform into the Ga-N_6 bond structures, resulting in an increase of the 418 cm^{-1} peak in the Raman spectrum, as observed in Fig. 2. However, when the nitridation temperature is high enough, unstable Ga-N_6 bonds will change into stable Ga-N_4 bonds. This accounts for the reduction of 418 cm^{-1} Raman peak intensity from the samples nitrided at 950°C and above. Such an argument is supported by additional experimental spectra as presented below.

Figure 4 depicts three Raman spectra of Ga_2O_3 nanowires nitrided at higher temperatures. The top and middle ones are the Raman spectra from the samples nitrided in ammonia at 1100°C for 20 and 30 min, respectively, while the bottom is from a sample nitrided at 1150°C for 20 min. The Raman signals from Ga_2O_3 components are no longer observed in these spectra, indicating that almost complete nitridation of Ga_2O_3 has occurred under these conditions. In comparison with the top and bottom spectra, the 418 cm^{-1} peak for the middle spectrum that corresponds to the longer nitridation time is greatly enhanced. This implies that increasing nitridation time favors the formation of the unstable Ga-N_6 bonds giving the 418 cm^{-1} peak. However, higher treatment temperature results in the transformation of the unstable Ga-N_6 bond structure to the stable Ga-N_4 phase, as indicated by the bottom spectrum in Fig. 4. Here, the peak at 565 cm^{-1} , which corresponds to the E_2 (high) mode of hexagonal crystalline ZnO, becomes sharper and more dominant, indicating a higher quality hexagonal phase of ZnO.^{4,16}

From the discussions given above and the structural nature of octahedral structure, the formation of Ga-N_6 bond structures requires two conditions, namely, a nitrogen rich condition and a local loosened lattice environment. In fact, all the GaN nanostructures reported in the literature showing the 418 cm^{-1} Raman peak were obtained in N_2 or NH_3 am-

biance providing an excellent N-rich environment.^{3-5,8,17} Even in the case of ion-implanted GaN,¹⁸ the N-rich local defected structures with the loosened lattice spacing were formed as Ga atoms are more easily displaced than N atoms. In our case, the original $\beta\text{-Ga}_2\text{O}_3$ lattice provides an ideal environment for the formation of local Ga-N_6 octahedral structures during the nitridation due to the existence of Ga-O_6 octahedra, thus explaining the remarkable vibration mode at 418 cm^{-1} in the GaN nanowires as obtained by nitriding $\beta\text{-Ga}_2\text{O}_3$ nanowires. It is worth mentioning that a reversed phase transition of GaN from tetrahedrally bonded structure to an octahedrally bonded structure under high pressure has been realized.^{19,20} We also note that in an earlier theoretical work done by Sun *et al.*,²¹ it was pointed out that “nonbonding” lone pairs exist on the nitride surface and can lower the Raman frequencies of vibration modes. The experimental results presented in the present study seem consistent with their theoretical prediction although there is no quantitative estimation of the Raman frequency shifts available.

In conclusion, we have shown that the vibrational mode at 418 cm^{-1} frequently observed in GaN nanostructures most likely originates from octahedrally bonded GaN structures. This conclusion is strongly supported by the observed evolution of the 418 cm^{-1} mode under postnitridation conditions of $\beta\text{-Ga}_2\text{O}_3$ nanowires grown on Si substrates.

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